•	Search Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination	_
09/954,799	HINCK ET AL.	
Examiner	Art Unit	_
Erin M. File	2634	

	SEARCHED		
Class	Subclass	Date	Examiner
375	376	10/10/2005	EMF
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST US PAT, USPGPUB, EPO, JPO DERWENT, IBM (text search only—see search history printout)	10/10/2005	EMF